

2nd generation thinQ![™] SiC Schottky Diode

FEATURES:

Applications:

al - • SMPS, PFC, snubber



- Revolutionary semiconductor material -Silicon Carbide
- Switching behavior benchmark
- No reverse recovery
- No temperature influence on the switching behavior
- No forward recovery
- High surge current capability

| Chip Type | V _{BR} | IF | Die Size | Package |
|-----------|-----------------|----|------------------------------|--------------|
| IDC06S60C | 600V | 6A | 1.45 x 1.354 mm ² | sawn on foil |

MECHANICAL PARAMETER:

| Raster size | 1.45x 1.354 | mm | | | |
|---------------------------------|---|-----------------|--|--|--|
| Anode pad size | 1.213 x 1.117 | | | | |
| Area total / active | 1.96 / 1.46 | mm ² | | | |
| Thickness | 355 | μm | | | |
| Wafer size | 75 | mm | | | |
| Flat position | 0 | deg | | | |
| Max. possible chips per wafer | 1861 pcs | | | | |
| Passivation frontside | Photoimide | | | | |
| Anode metalization | 3200 nm Al | | | | |
| Cathode metalization | 1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding | | | | |
| Die bond | Electrically conductive glue or solder | | | | |
| Wire bond | AI, ≤ 350µm | | | | |
| Reject Ink Dot Size | $arnothing \ge 0.3 \ \text{mm}$ | | | | |
| Recommended Storage Environment | store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C | | | | |



Maximum Ratings

| Parameter | Symbol | Condition | Value | Unit | |
|--|-----------------------------------|---|---------|------|--|
| Repetitive peak reverse voltage | V _{RRM} | | 600 | V | |
| DC blocking voltage | V _{DC} | | 600 | | |
| Continuous forward current limited by T _{jmax} | I _F | | 6 | | |
| Surge non repetitive forward current sine halfwave | I _{F,SM} | $T_C = 25^{\circ}C, t_P = 10 ms$ | 49 | А | |
| Repetitive peak forward current limited by T _{jmax} | I _{F,RM} | $T_C = 100^{\circ}C, T_j = 150^{\circ}C, D = 0.1$ | 28 | | |
| Non-repetitive peak forward current | l _{F,max} | T _C =25°C, tp=10μs | 210 | | |
| Operating junction and storage temperature | T _j , T _{stg} | | -55+175 | °C | |

Static Electrical Characteristics (tested on chip), T_i=25 °C, unless otherwise specified

| Parameter | Symbol | Condi | Value | | | Unit | |
|-----------------------|----------------|----------------------|-------------------------------------|------|------|------|----|
| T di dificici | Gymbol | Conditions | | min. | Тур. | max. | |
| Reverse current | I _R | V _R =600V | <i>T_j</i> =25 ° <i>C</i> | | 0.7 | 80 | μA |
| Diode forward voltage | V _F | I _F =6A | <i>T_j</i> =25°C | | 1.5 | 1.7 | V |

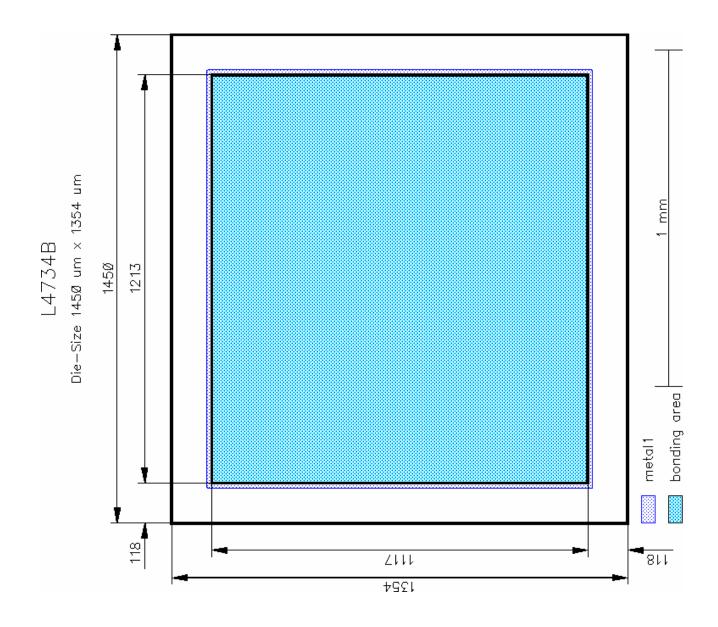
Dynamic Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified, tested at component

| Parameter | Symbol | Conditions | | Value | | | Unit |
|------------------------------|----------------|---|------------------------|-------|------|------|------|
| | Symbol | | | min. | Тур. | max. | Unit |
| Total capacitive charge | Q _C | $I_F <= I_{F,max}$ di/dt = 200 A/ms $V_P = 400 V$ | $T_j = 150 \ ^\circ C$ | | 15 | | nC |
| Switching time ¹⁾ | t _c | | $T_j = 150 \ ^\circ C$ | | | <10 | ns |
| Total capacitance | с | f=1MHz | $V_R = 1 V$ | | 280 | | |
| | | | V _R =300V | | 35 | | pF |
| | | | V _R =600V | | 35 | | |

 $^{1)}$ t_{c} is the time constant for the capacitive displacement current waveform (independent from T_{j} , I_{LOAD} and di/dt), different from t_{rr} which is dependent on T_{j} , I_{LOAD} and di/dt. No reverse recovery time constant t_{rr} due to absence of minority carrier injection



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

INFINEON TECHNOLOGIES

IDT06S60C

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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